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Spin-Orbit-Enhanced Robustness of Supercurrent in Graphene/WS₂ Josephson Junctions

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We demonstrate the enhanced robustness of the supercurrent through graphene-based Josephson junctions in which strong spin-orbit interactions (SOIs) are induced. We compare the persistence of a supercurrent at high out-of-plane magnetic fields between Josephson junctions with graphene on hexagonal boron-nitride and graphene on WS₂, where strong SOIs are induced via the proximity effect. We find that in the shortest junctions both systems display signatures of induced superconductivity, characterized by a suppressed differential resistance at a low current, in magnetic fields up to 1 T. In longer junctions, however, only graphene on WS₂ exhibits induced superconductivity features in such high magnetic fields, and they even persist up to 7 T. We argue that these robust superconducting signatures arise from quasiballistic edge states stabilized by the strong SOIs induced in graphene by WS₂.

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Magnetic fields are known to be detrimental to ordinary s-wave superconductivity because of the pair-breaking effect of the Zeeman component, which can flip the spins in the spin-singlet Cooper pair [1]. Magnetic fields also affect superconductivity via an orbital effect, a geometrydependent dephasing of Cooper pairs by the vector potential. This orbital effect determines the field-dependent interference pattern of the critical current in spatially extended Josephson junctions [2,3].

Spin-orbit interactions (SOIs) play a crucial role in mitigating these field-induced pair-breaking effects. Recently, Ising pairing in transition-metal dichalcogenides (TMDs) was found to confer the robustness of superconductivity owing to spin-momentum locking, by which the spin polarization of Cooper pairs is prevented [4–6]. While the role of SOIs in stabilizing the spin component of the Cooper pair was emphasized in many previous studies, the effect of SOIs on orbital depairing is only beginning to be explored [7,8].

In this Letter, we demonstrate that SOIs can enhance the superconducting proximity effect in high out-of-plane magnetic fields in graphene-on-WS₂-based Josephson junctions. These junctions consist of graphene encapsulated between hexagonal boron nitride (hBN) and WS₂, which induces strong SOIs in graphene via the proximity effect [9–15]. The magnetic field dependence of the critical current through graphene-based superconductor–normal-metal– superconductor junctions has been already extensively studied [16–18]. It is characterized by a Fraunhofer-like pattern resulting from interference between the uniformly distributed Andreev pair trajectories and decays rapidly at fields above a few flux quanta through the sample. However, specifically in very clean short ballistic junctions, residual supercurrent periodic oscillations at very high fields were observed and associated with the physics of the quantum Hall (QH) effect [19]. Here, we investigate junctions in the opposite, diffusive limit. The junction lengths (L) range between 100 and 500 nm from the short- to long-junction regimes. Although the junctions are diffusive, surprisingly, we find clear signatures of induced superconductivity with manifestations of a supercurrent even in magnetic fields in the Tesla range for the graphene-on-WS₂ junctions. By contrast, this behavior is not observed for graphene-onhBN junctions outside the short ballistic regime, i.e., for lengths greater than L = 200 nm. We argue that this robust induced superconductivity arises from quasiballistic trajectories along the sample edges, stabilized by strong SOIs induced in graphene by WS₂.

We compare two types of samples: $hBN/graphene/WS_2$ (Gr/WS₂) and hBN/graphene/hBN (Gr/hBN) junctions. Graphene and hBN are mechanically exfoliated from graphite and hBN crystals, and monolayer WS₂ flakes are grown by chemical vapor deposition [11,20]. hBN and graphene are picked up by the typical dry-transfer technique with polydimethylsiloxane and polypropylene carbonate and then



FIG. 1. Device structure and transport properties around zero magnetic field. (a) Schematic illustration of a graphene-based Josephson junction device of length *L* and width *W* employed in this study. (b) V_g dependence of *R* for the Gr/WS₂ and Gr/hBN junctions with MoRe in the normal state (L = 500 nm). The contact resistance is subtracted in the data. (c),(d) Color-coded dV/dI, plotted as a function of I_{dc} and *B* for Gr/WS₂ [(c)] and Gr/hBN junctions [(d)] with L = 500 nm measured at $V_g = 60$ V.

deposited onto WS₂ or hBN [21]. One-dimensional superconducting contacts are patterned by electron beam lithography, followed by reactive ion etching and sputtering 100 nm MoRe. MoRe is a type-II superconductor with high critical field $H_{c2} \sim 80\,000$ G (8 T) and critical temperature $T_c \sim 10$ K [19]. The junctions are defined by their length (*L*) and width (*W*), $W \sim 10 \ \mu$ m for all samples, whereas *L* varies between 100 and 500 nm [see Fig. 1(a)]. Measurements are performed in a dilution refrigerator, at 100 mK unless otherwise specified, using a conventional lock-in technique.

We previously demonstrated via weak antilocalization that graphene on TMDs acquires by proximity strong SOIs thanks to the heavy elements such as molybdenum (Mo) or tungsten (W) that they contain [11,13,22]. While the intrinsic SOI in graphene is small (24 μ eV) [23], it is enhanced by contact with a TMD flake, up to 1 meV–10 meV depending on the type and thickness of the TMDs. Specifically, it was found that monolayer tungsten-based TMDs such as WS₂ or WSe₂ induce the strongest SOIs in graphene [11,13]. Therefore, our Gr/WS₂ junctions include graphene with strong SOIs as a normal region. Since the resistivity of the TMDs is much larger than that of graphene, the electrical current can be considered to flow entirely through the graphene in the Gr/TMD bilayer.

We first discuss the results in the normal state. Figure 1(b) displays a typical gate voltage (V_g) dependence of the resistance (R) for Gr/WS₂ and Gr/hBN junctions (L = 500 nm) measured above the T_c of MoRe in zero field. The Dirac

peak is sharper in the Gr/hBN junction than in the Gr/WS_2 , indicating that the mobility of graphene on hBN is higher than that of graphene on WS_2 . While it is reported that multilayered TMD flakes may constitute as flat and clean substrates for graphene as hBN [24], we note that in our experiments we work with monolayer TMD grown by chemical vapor deposition, which may contain polymer residues left over from the transfer process to the sample substrates and which also is not as flat as the multilayer hBN used for the Gr/hBN junctions. In fact, all the Gr/ hBN junctions have higher mobility than the Gr/WS₂ junctions. Particularly, the Gr/hBN junction with L =100 nm displays oscillations of R with V_q in the holedoped region, consistent with previous reports of Fabry-Pérot oscillations [16–18]. This is also in agreement with our estimate of a mean free path $l_e \sim 100$ nm from diffusive samples whose L is longer than l_e . Interestingly, Fabry-Pérot oscillations are not observed in Gr/WS₂ junctions even for L = 100 nm, consistent with the lower mobility of Gr/WS_2 junctions [25].

After cooling the sample below T_c of the superconducting contacts, we measured the differential resistance (dV/dI) as a function of the dc current (I_{dc}) and magnetic field (B) around zero field. A small ac current I_{ac} was added to I_{dc} , and the corresponding ac voltage was detected by a lock-in amplifier, yielding dV/dI. Figure 1(c),(d) displays the color-coded dV/dI of Gr/WS₂ and Gr/hBN junctions [L = 500 nm, same samples as Fig. 1(b)] as a function of I_{dc} and B at low fields. Both samples exhibit clear regions with zero dV/dI at a low dc current, corresponding to an induced supercurrent. Deviations from the typical Fraunhofer pattern are presumably due to current inhomonegeities through the junctions. We note that the critical current (I_c), defined by I_{dc} at which dV/dI is maximum, is larger for the Gr/hBN junction than that for the Gr/WS₂ junction. This indicates that the induced superconductivity is stronger for the Gr/hBN junction at low fields and is consistent with the higher mobility of the Gr/hBN junctions [see Fig. 1(b)].

The low field behavior displayed in Fig. 1(c),(d) is the expected Fraunhofer-like interference pattern for a supercurrent flowing uniformly throughout the entire width of the graphene sheet [1–3]. Whereas the value of I_c varies for different junctions, similar behaviors are observed for all junctions. The oscillation period corresponds to the junction area if the magnetic focusing effect is taken into account [25,27,28].

To investigate the induced superconductivity at high fields, we next increased *B* around 1 T (10000 G) and similarly measured dV/dI as a function of I_{dc} and *B*. Figure 2 compares Gr/WS₂ and Gr/hBN junctions with different *L* (*L* = 100, 300, and 500 nm). Considering the relation between the Thouless energy ($E_T = \hbar D/L^2$ with the diffusion constant *D* in the diffusive regime and $E_T = \hbar v_F/L$ in the ballistic regime) and the superconducting gap Δ_0 (= 1 meV) of MoRe, both *L* = 100 nm junctions are



FIG. 2. Color-coded dV/dI as a function I_{dc} and B around B = 10000 G at $V_g = 60$ V for all samples. For L = 100 nm [(a),(d)], superconducting pockets are clearly visible, in the form of field regions of low dV/dI at low I_{dc} , for both the Gr/WS₂ and Gr/hBN junctions around B = 8000 G. For L = 300 nm [(b),(e)] and L = 500 nm [(c),(f)], superconducting pockets are visible only for the Gr/WS₂ junction. (g)–(i) Cross-sectional image along the light blue line shown in (a)–(f) of dV/dI as a function of I_{dc} for Gr/WS₂ and Gr/hBN junctions with different L. Red and light green curves are from Gr/WS₂ and Gr/hBN junctions, respectively. The suppressed dV/dI at low I_{dc} , signature of an induced superconducting proximity effect, is clearly visible for the Gr/WS₂ junctions of every length but only for the shortest Gr/hBN junction. In (g), the peak (or bump) of dV/dI for Gr/hBN is located out of the range of I_{dc} in the measurement, and in (h) [(i)], the dV/dI for Gr/hBN (Gr/WS₂) is vertically shifted to compare to that for Gr/WS₂ (Gr/hBN). The residual resistance around 50 Ω at $I_{dc} = 0$ for (a)–(i) arises from the measurement wires. The dashed line in (g) represents the value of I_{dc} , which defines I_c .

in the short-junction limit ($E_T > \Delta$), while the others are in the long-junction limit ($E_T < \Delta$). Interestingly, for the shortest, L = 100 nm, junctions, a relatively large 100 nAwide dip of dV/dI is observed in certain fields, even around 8000 G for both Gr/WS₂ and Gr/hBN junctions, and oscillates as a function of *B*. In the previous study on graphene ballistic Josephson junctions [16], fielddependent and sample-specific differential resistance dips at a low current were also observed around 5000 G, and the *B* and V_g regions of low dV/dI were termed "superconducting pockets." In our shortest samples, the superconducting pockets are still visible around B = 16000 G for the Gr/WS₂ junction. We note that all Gr/WS₂ junctions, even the shortest one with L = 100 nm, are in the diffusive limit because of the shorter l_e .

Whereas the field dependence is similar for both types of 100-nm-long junctions, we find a stark difference for the longer junctions, L = 300 and 500 nm. While superconducting pockets persist around B = 10000 G for

 Gr/WS_2 , they are clearly suppressed for Gr/hBN. We note that the typical oscillation field scale of the superconducting pockets is about 1.5 G, identical to the width of the Fraunhofer-like pattern main lobe.

Beyond these dV/dI maps as a function of I_{dc} and B in limited field regions, a broader picture can be obtained by following dV/dI at zero dc current bias (ZBR) over a wide range of B. ZBR oscillates between the normal state resistance when no superconductivity is induced and has a minimal dV/dI in the middle of the superconducting pocket when the superconducting proximity effect is strongest. Figure 3 shows the ZBR as a function of Bfor all junctions. For L = 100 nm, the ZBR oscillates with a large amplitude both for Gr/WS₂ and Gr/hBN, even near B = 18000 G. On the contrary, for L = 300 nm, oscillations are strongly suppressed, especially for B > 5000 G for Gr/hBN, while they persist for Gr/WS₂ even at higher fields. The difference is even more striking for the L = 500 nm junctions. The oscillation amplitudes are



FIG. 3. Monitoring the superconducting proximity effect over a wide field range, via the zero bias differential resistance variations with *B*, for the three junction lengths and both Gr/WS₂ and Gr/hBN systems, at $V_g = 60$ V. (a) For L = 100 nm, both Gr/WS₂ and Gr/hBN junctions display comparable oscillation amplitudes up to $B \sim 20000$ G. (b) For L = 300 nm, whereas the Gr/hBN junction displays larger amplitude oscillations near B = 0, they are rapidly suppressed as *B* increases. By contrast, the Gr/WS₂ junction displays a relatively large amplitude of resistance oscillations that persists even around 20 000 G. (c) The difference between Gr/WS₂ and Gr/hBN is the most striking for L = 500 nm junctions. The relative oscillation amplitude of the Gr/WS₂ junction's differential resistance is around 50 times greater than that of the Gr/hBN junction over the entire field range. The inset in (b) displays a magnified view of the oscillations for Gr/WS₂ around B = 13000 G.

considerably different already at a small field, and large oscillations are visible at B = 18000 G for Gr/WS₂, while Gr/hBN exhibits almost no oscillations over the entire *B* range. In [25], we provide the whole data from the L = 500 nm Gr/WS₂ junction, displaying how the oscillations persist up to 70 000 G. These results demonstrate that superconducting pockets can persist at much higher fields for Gr/WS₂ than for Gr/hBN, in the longest junctions.

We now discuss possible mechanisms by which SOIs can enhance the robustness of the induced superconductivity at high fields. Superconducting pockets at high fields have already been discussed for ballistic junctions [16] in terms of Andreev bound states mediated by chaotic ballistic billiard paths localized at the edges of graphene. Those paths can be considered a ballistic analog of the quasiclassical phase-coherent paths and produce mesoscopic fluctuations of the supercurrent $\delta I_c = \sqrt{\langle I_c^2 \rangle - \langle I_c \rangle^2}$ [29]. In the ballistic short junction limit, δI_c is estimated as [30]

$$\delta I_c \sim \frac{e\Delta_0}{\hbar},\tag{1}$$

where Δ_0 denotes the superconducting gap at T = 0. In the diffusive long-junction limit [29,31],

$$\delta I_c \sim \frac{eE_T}{\hbar} \sqrt{\frac{W}{L}}.$$
 (2)

We find $\delta I_c \sim 240$ nA from Eq. (1) expected to be adequate for short Gr/hBN junctions but slightly larger than our experimental value. Reduced experimental values compared to the theoretical ones were already reported [32,33] and may be attributed to barriers at the normalmetal-superconductor interface, along with electromagnetic noise or finite temperature effects. We then estimate δI_c for diffusive junctions by using Eq. (2) and obtain $\delta I_c \sim 100$ nA and 50 nA for L = 300 and 500 nm, respectively. The latter is in almost perfect agreement with the experimental result, while the former is larger than the experimental value. However, Eqs. (1) and (2) were evaluated for zero field. The field dependence of the critical current was recently theoretically investigated in twodimensional ballistic junctions similar to our samples [34]. As B increases, the supercurrent is localized near the edges, and I_c decays faster $(I_c \propto 1/B^2)$ than the typical current fluctuations δI_c [34]. Moreover, those fluctuations can persist up to high fields for edges whose roughness is characterized by a correlation length of the order of or larger than the Fermi wavelength. In these conditions, they find $\delta I_c = \alpha E_T / \Phi_0$, independent of field, which corresponds to the current carried by one ballistic channel, with $\alpha = 2\pi/9\sqrt{3}$. This yields $\delta I_c \sim 200$ nA for the 100-nmlong Gr/hBN junction, in qualitative agreement with our experimental findings. These high field fluctuations are specific to ballistic junctions and therefore not expected in the diffusive regime.

In order to explain the robust supercurrent signatures that we find in the diffusive Gr/WS₂ junctions, it therefore seems necessary to consider the role of SOIs. SOIs favor the formation of edge states, epitomized by the topological quantum spin Hall phase. However, edge states can also exist in a nontopological system and coexist with bulk states of the same energy. Such edge states are in general sensitive to scattering, but some degree of protection against smooth disorder may exist if the edge states are well separated from bulk states in momentum space. Moreover, spin can also provide additional protection if the spins of the edge state and those of the nearby bulk band are opposite. In the case of graphene on WS_2 , the analysis of weak antilocalization experiments [11–13] has shown that the induced SOIs have both a Rashba-type in-plane component and a tenfold larger out-of-plane component,

predominantly of the valley Zeeman type probably [14,15]. The combined effect of these two types of interactions was theoretically shown to generate nontopological edge states along zigzag edges [35]. To explore whether such edge states may explain the persistence and oscillations of supercurrent at high fields, we have performed simulations of I_c as a function of B in graphene stripes containing different types of SOIs [25]. We find that a supercurrent persists up to higher fields with SOIs than without SOIs, even when disorder is included.

We now examine the relation between these edge paths and the chiral edge states of the QH regime. The QH regime develops when the mean free path $l_e \gg 2r_c$, where r_c is the cyclotron radius ($r_c = \hbar k_F / eB$) [19]. At $V_q = 60$ V and B = 10000 G, for example, $2r_c \sim 500$ nm, thus chiral edge states do not contribute to the Andreev bound states localized at the edge. We note that this $2r_c$ value is much larger than $l_e = 30$ nm of L = 500 nm Gr/WS₂ junction. At higher fields, r_c becomes smaller than l_e , so that the Landau localization of bulk states and the formation of chiral edge states may become relevant. We observe superconducting pockets even at 70000 G for the Gr/WS₂ junction for L = 500 nm, and $\delta I_c \sim 30$ nA [25]. This value is, however, more than 1 order of magnitude larger than δI_c reported in the QH regime with a comparable r_c for shorter and narrower junctions with better quality graphene [19]. This may indicate that the supercurrent enhancement by the SOIs can also be effective in the QH regime.

Another effect of SOIs recently suggested theoretically is the generation of spin-triplet supercurrent flowing close to the edge in combination with magnetic field or exchange interaction in superconductor-normal-metalsuperconductor junctions [36-39]. The characteristic confinement length in this case should be the spin-orbit length (λ_{so}) , estimated to be of the order of a few hundred nm for graphene with strong SOIs. Such a large extent would lead to a supercurrent suppression for fields much below the 10 000 gauss range, so that this effect cannot explain the strong lateral confinement we observe. Another interesting possibility, edge supercurrents induced by two-dimensional vortex lattice formation because of Fermi surface warping [40], also seems unlikely because such Fermi surface warping was not observed in the previous angular-resolved photoemission spectroscopy of similar graphene/ WS_2 samples [41].

In conclusion, we have demonstrated robust proximityinduced superconductivity that persists in high magnetic fields for Gr/WS_2 Josephson junctions. Compared to the Gr/hBN control samples, all Gr/WS_2 junctions (with *L* between 100 and 500 nm) have lower mobility and are in the diffusive regime. Nevertheless, and most strikingly for longer junctions, superconducting pockets are still observable at 70 000 G, whereas they are suppressed for Gr/hBN junctions with the same *L*. We argue that these robust superconducting signatures stem from quasiballistic states confined along the samples edges, stabilized by the SOIs. Because these edge states carry supercurrent at the micrometer scale, one could envisage further investigations, for instance using more elaborate structures for transport measurements, as well as other techniques such as STM or orbital magnetism measurements. Our findings provide important information for progress toward topological superconductivity in which the combined effects of superconductivity and SOIs play crucial roles.

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